

Notice of References Cited	Application/Control No. 10/706,050	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner HOAN C. NGUYEN	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,657,004	08-1997	Whittaker et al.	340/815.45
*	B	US-2004/0114396	06-2004	Kobayashi et al.	362/561
	C	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002006815	01-2002	JP	Yano et al.	
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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